









Release Date: 15 April 2019 Version: A2.1

# PRODUCT DATASHEET



- ► Ceramic High Power
- ➤ 3535 2.22t Series
- ▶ Ultraviolet (390-400nm)

NOQ10S91Z (3mm Lens)







3535 2.22t Series





## **FEATURES:**

- Package: Ceramic SMT Package with Silicon Lens
- Forward Current: 500-700mA Forward Voltage (typ.): 3.4V

3535 2.22t Series

- Radiant Power (typ.): 780mW@500mA; 1037mW@700mA
- Colour: Ultraviolet (UV) Peak Wavelength: 390-400nm
- Viewing angle: 125°
- **Materials:** 
  - Die: InGaN
  - Resin: Silicon (Water Clear)
  - L/T Finish: Gold (Au)
- Operating Temperature: -40~+85°C
- Storage Temperature: -40~+100°C
- **Grouping parameters:** 
  - Forward Voltage
  - **Radiant Power**
  - Peak Wavelength
- Soldering methods: Reflow
- Moisture Sensitive Level: MSL2 according to J-STD020
- Packing: 12mm tape with Max.1000pcs/reel, ø180mm (7")

#### **APPLICATIONS:**

- **Industrial Curing**
- Air Purifier
- **Poster Printing Curing**
- Counterfeit Money Detector
- **Blood Detector**
- **Nail Curing**
- **Teeth Curing**



#### **CHARACTERISTICS:**

## Absolute Maximum Characteristics (Ta=25°C)

Parameter	Symbol	Ratings	Unit
DC Forward Current	IF	700	mA
Reverse Current @5V	I <sub>R</sub>	10	μΑ
Junction Temperature	Tj	90	°C
Electrostatic Discharge (HBM: MIL-STD-883 C:3B)	ESD	8000	V
Operating Temperature	T <sub>OPR</sub>	-40~+85	°C
Storage Temperature	T <sub>STG</sub>	-40~+100	°C
Soldering Temperature	T <sub>SOL</sub>	250	°C
Thermal Resistance - Junction to Solder Point	R <sub>th</sub>	8	°C/W

## Electrical & Optical Characteristics (Ta=25°C)

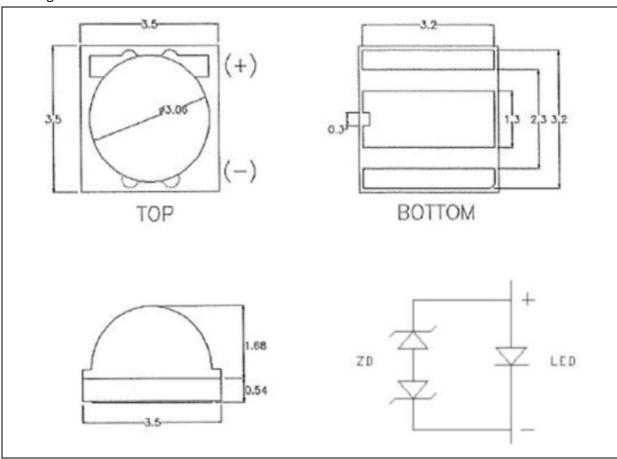
Darameter	Cumbal	Values			Unit	Test
Parameter	Symbol	Min.	Тур.	Max.	Onit	Condition
Forward Voltage	V <sub>F</sub>	2.8	3.4	4.0	V	I <sub>F</sub> =500mA
Radiant Power		445	560	675		I <sub>F</sub> =350mA
	Po	620	780	940	mW	I <sub>F</sub> =500mA
		824	1037	1250		I <sub>F</sub> =700mA
Radiant Intensity	le		210			I <sub>F</sub> =350mA
			295		mW/sr	I <sub>F</sub> =500mA
			390			I <sub>F</sub> =700mA
Peak Wavelength	$\lambda_{D}$	390		400	nm	I <sub>F</sub> =500mA
Viewing Angle	2θ <sub>1/2</sub>		125		deg	I <sub>F</sub> =500mA

- 1. Radiant power  $(\Phi_V)$  ±7%, Forward Voltage  $(V_F)$  ±0.05V, Viewing angle $(2\theta_{1/2})$  ±10°, Peak wavelength  $(\lambda_D)$  ±1nm.
- IS standard testing



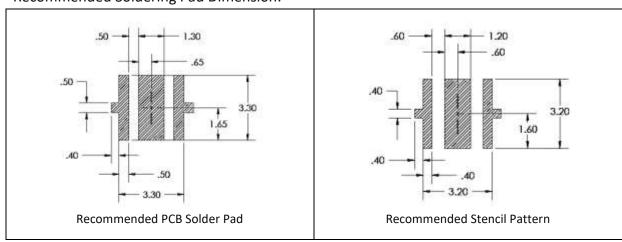
#### **OUTLINE DIMENSION:**

#### Package Dimension:



- 1. All dimensions are in millimetre (mm).
- 2. Tolerance ±0.13mm, unless otherwise noted.

### **Recommended Soldering Pad Dimension:**



- 1. Dimensions are in millimetre (mm).
- 2. Tolerance ±0.12mm with angle tolerance ±0.5°.



## **BINNING GROUPS:**

## Forward Voltage Classifications (I<sub>F</sub> = 500mA):

Code	Min.	Max.	Unit
V2830	2.8	3.0	
V3032	3.0	3.2	
V3234	3.2	3.4	V
V3436	3.4	3.6	V
V3638	3.6	3.8	
V3840	3.8	4.0	

## Radiant Power Classifications (I<sub>F</sub> = 500mA):

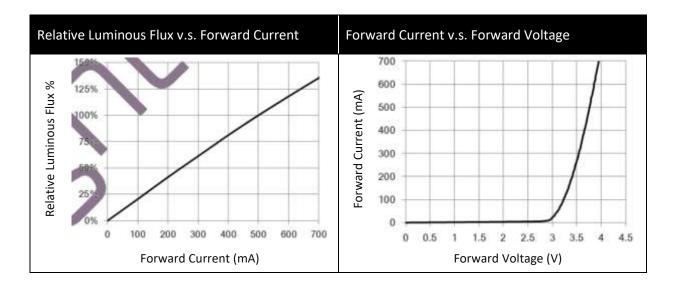
Code	Min.	Max.	Unit
U062	620	660	
U066	660	700	
U070	700	740	
U074	740	780	mW
U078	780	820	IIIVV
U082	820	860	
U086	860	900	
U090	900	940	

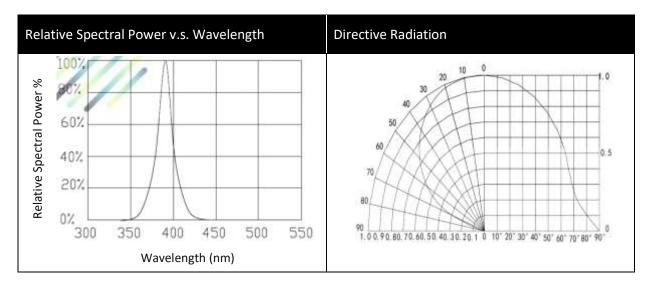
## Peak Wavelength Classifications (I<sub>F</sub> = 500mA):

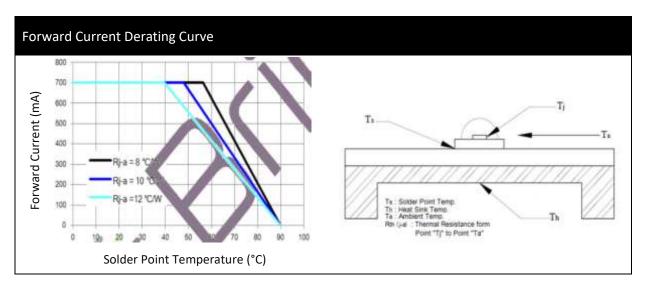
Code	Min.	Max.	Unit
Q390	390	395	
Q395	395	400	nm



#### **ELECTRO-OPTICAL CHARACTERISTICS:**



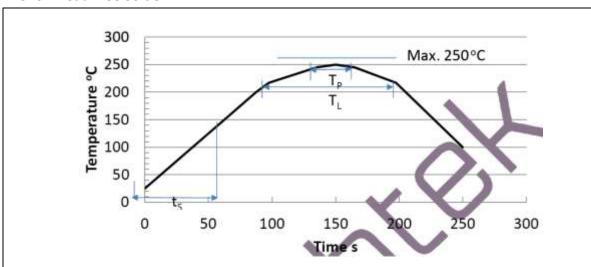






#### **RECOMMENDED SOLDERING PROFILE:**

#### Reflow Lead-free Solder:



Duelle Control	Combal.	Pb-Free (SnAgCu) Assembly			100000
Profile Feature	Symbol	Minimum	Recommendation	Maximum	Unit
Ramp-up Rate to Preheat (25°C to 150°C			2	3	K/s
Time ts (Tsmin to Tsmax)	ts	60	100	120	5
Ramp-up Rate to Peak (T <sub>Smax</sub> to T <sub>P</sub> )	•		2	3	K/s
Liquidus Temperature	T <sub>L</sub>		217		°C
Time above Liquidus temperature	t <sub>L</sub>		80	100	s
Peak Temperature	Тр		245	250	°C
Time within 5 °C of the specified peaktemperature T <sub>P</sub> - 5 K	t <sub>p</sub>	10	20	30	s
Ramp-down Rate (T <sub>P</sub> to 100 °C)			3	4	K/s
Time 25 °C to T <sub>P</sub>				480	5

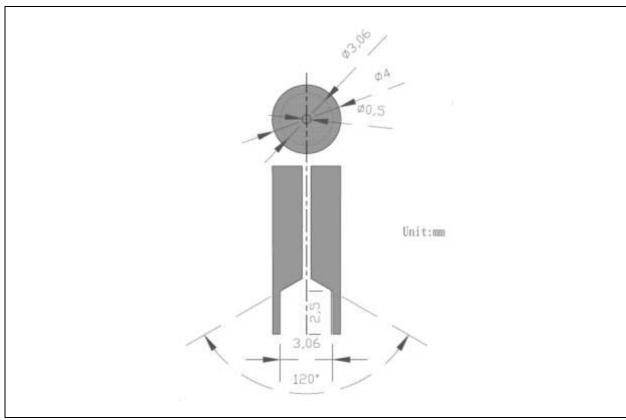
#### Note:

- 1. Recommend reflow temperature 240°C. The maximum soldering temperature should be limited to 250°C.
- 2. Maximum reflow soldering: 2 times.
- 3. Before, during, and after soldering, should not apply stress on the components and PCB board.



## **RECOMMENDED NOZZLE FOR SMT:**

#### Recommended Pick & Place Nozzle:

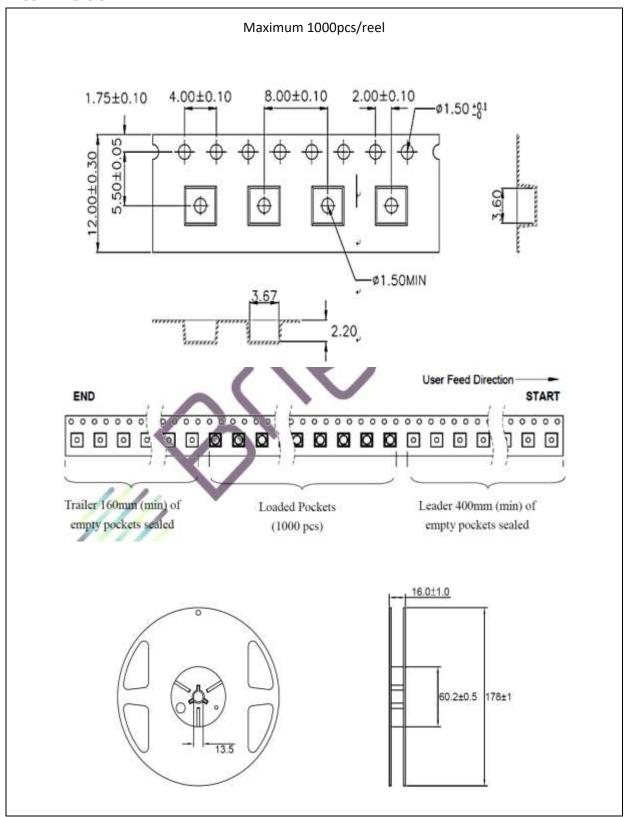


- 1. All dimensions are in millimetre (mm).
- 2. Tolerance ±0.1mm, unless otherwise noted.



#### **PACKING SPECIFICATION:**

#### Reel Dimension:





#### **PRECAUTIONS OF USE:**

#### Storage:

It is recommended to store the products in the following conditions:

- Humidity: 60% R.H. Max.
- Temperature: 5°C~30°C (41°F ~86°F).

Shelf life in sealed bag: 12 months at 5°C~30°C and <60% R.H.

Once the package is opened, the products should be used within a week. Otherwise, they should be kept in a damp-proof box with descanting agent and apply baking.

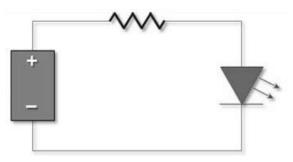
#### Baking:

It is recommended to bake the LED before soldering if the pack has been unsealed for longer than 24hrs. The suggested baking conditions are as followings:

• 60±3°C x 24hrs and <5%RH, taped / reel package.

It's normal to see slight color fading of carrier (light yellow) after baking in process.

#### **Testing Circuit:**



Must apply resistor(s) for protection (over current proof).

#### Cleaning:

Use alcohol-based cleaning solvents such as isopropyl alcohol to clean the LED carrier / package. Avoid putting any stress force directly on to the LED lens.

### ESD (Electrostatic Discharge):

Static Electricity or power surge will damage the LED. Use of a conductive wrist band or anti-electrosatic glove is recommended when handing the LED all time. All devices, equipment, machinery, work tables, and storage racks must be properly grounded.

In the events of manual working in process, make sure the devices are well protected from ESD at any time.



# **Test Items and Reliability:**

Test Item	Test Condition	Duration / Cycle	Failure Rate	Reference
Thermal Shock	-40°C 30mins ↓↑ 5mins 125°C 30mins	100 cycles	0/22	AEC-Q101
High Temperature Storage	Ta=100°C	1000hrs	0/22	EIAJ ED-4701 200 201
Humidity Heat Storage	Ta=85°C RH=85%	1000hrs	0/22	EIAJ ED-4701 100 103
Low Temperature Storage	Ta=-40°C	1000hrs	0/22	EIAJ ED-4701 200 202
Life Test	Ta=25°C I <sub>F</sub> =500Ma	1000hrs	0/22	
High Humidity Heat Operation	85°C RH=85% I <sub>F</sub> =500Ma	1000hrs	0/22	
High Temperature Operation	Ta=85°C I <sub>F</sub> =500Ma	1000hrs	0/22	
ESD (HBM)	8KV at 1.5Kω 100pf	3 times	0/22	MIL-STD-883

Failure Criteria					
Item	Cumbal	Condition	Criteria for Judgment		
item	Symbol	Condition	Min	Max	
Forward Voltage	$V_{F}$	I <sub>F</sub> =500Ma	-	USL <sup>1</sup> x 1.1	
Reverse Current	I <sub>R</sub>	V <sub>R</sub> =5V	-	100μΑ	
Luminous Intensity	I <sub>V</sub>	I <sub>F</sub> =500Ma	LSL <sup>2</sup> x 0.7	-	

1. USL: Upper Specification Level.

2. LSL: Lower Specification Level.



## **REVISION RECORD:**

Version	Date	Summary of Revision
A1.0	28/07/2014	Datasheet set-up.
A1.1	29/08/2014	Add picture and starboard information.
A1.2	17/09/2014	Add radiant intensity.
A1.3	04/03/2015	Revised reel quantity.
A1.4	12/03/2015	Update photo and drawing.
A1.5	13/03/2015	Add radiant power and intensity information.
A1.6	16/03/2015	P/N adds suffix Z indicating with Zeners.
A1.7	26/03/2015	Mark with old P/N.
A1.8	19/05/2015	Dimension and characteristics update.
A1.9	20/05/2015	Add carton packing dimension.
A2.0	21/12/2016	Separate 390-400nm and 400-410nm into two part numbers.
A2.1	15/04/2019	Dom lens size changes to 3mm diameter and spec update.